

ABSTRACT

INSPECTION SUBSTRATE FOR DISPLAY DEVICE

In order to make it possible to easily detect an electrical defect by
5 using an array tester, the present inspection substrate includes: plural scan
lines and plural signal lines; plural storage capacitor lines arranged in
parallel to the scan lines; storage capacitor elements, each of which uses a
part of the storage capacitor line as one of electrodes thereof; storage
capacitor upper electrodes formed of the same layer as that for the signal
10 lines and electrically connected to the storage capacitor elements; switching
elements arranged on intersection points of the signal lines and the scan
lines and electrically connected to the storage capacitor elements; and
dummy wiring lines formed by use of at least one of two types of metals
constituting electrodes of the switching elements, and electrically connected
15 to any of the scan lines, the signal lines, the storage capacitor lines and the
storage capacitor upper electrodes.

FIG.3



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